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The S-29LXX1A Series is low power 1K/2K/4K-bit serial E<sup>2</sup>PROM with a low operating voltage range. They are organized as 64-word × 16-bit, 128-word × 16-bit and 256-word × 16-bit, respectively. Each is capable of sequential read, where addresses are automatically incremented in 16-bit blocks. The instruction code is compatible with the NM93CSXX Series.

The S-29LXX1A Series is capable of protecting the memory, 50% of which can be protected starting from address 00.

■ Features

- Low power consumption
  - Standby : 0.8 μA Max. (V<sub>CC</sub> = 5.5 V)
  - Operating : 0.8 mA Max. (V<sub>CC</sub> = 5.5 V)
  - : 0.4 mA Max. (V<sub>CC</sub> = 2.7 V)
- Low operating voltage range
  - Write : 1.8 to 5.5 V
  - Read : 1.8 to 5.5 V
- Sequential read capable
- Memory Protection
- Endurance : 10<sup>5</sup> cycles/word
- Data retention : 10 years
- S-29L131A : 1K bits NM93CS46 instruction code compatible
- S-29L221A : 2K bits NM93CS56 instruction code compatible
- S-29L331A : 4K bits NM93CS66 instruction code compatible

■ Pin Assignment

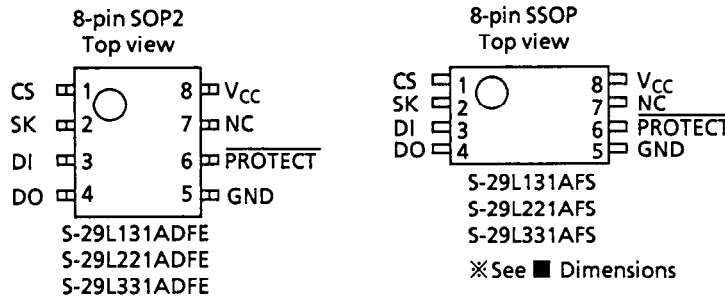


Figure 1

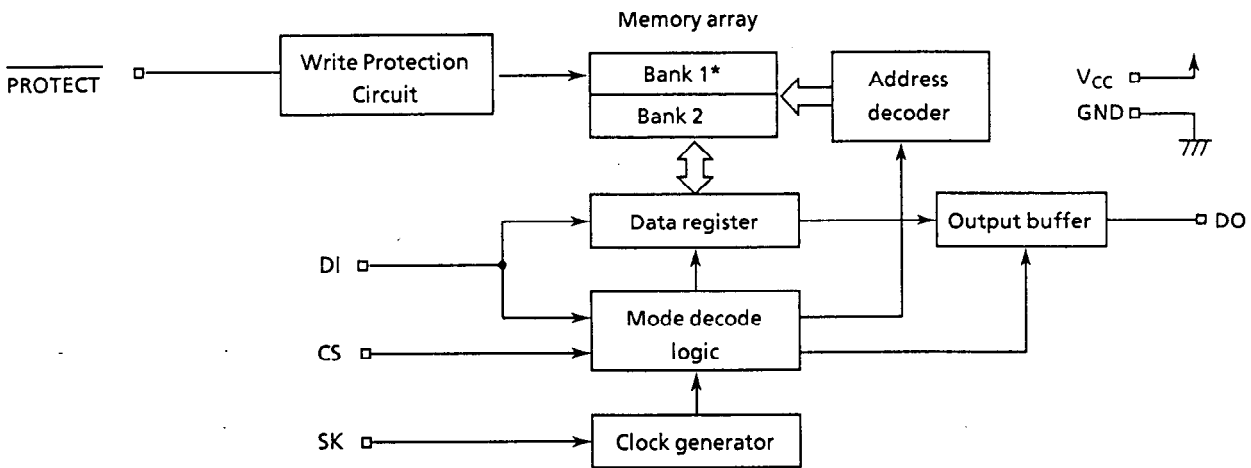
■ Pin Functions

Table 1

Name	Pin Number		Function
	SOP2	SSOP	
CS	1	1	Chip select input
SK	2	2	Serial clock input
DI	3	3	Serial data input
DO	4	4	Serial data output
GND	5	5	Ground
$\overline{\text{PROTECT}}$	6	6	Memory Protection Control Input Connected to GND or Open : Protection Valid Connected to V <sub>CC</sub> : Protection Invalid
NC	7	7	No Connection
V <sub>CC</sub>	8	8	Power supply

**CMOS SERIAL E<sup>2</sup>PROM  
S-29LXX1A Series**

■ **Block Diagram**



\* 50% of the memory can be protected starting from address 00

Figure 2

■ **Instruction Set**

Table 2

Instruction	Start Bit	Ope code	Address			Data
			S-29L131A	S-29L221A	S-29L331A	
READ (Read data)	1	10	A <sub>5</sub> to A <sub>0</sub>	XA <sub>6</sub> to A <sub>0</sub>	A <sub>7</sub> to A <sub>0</sub>	D <sub>15</sub> to D <sub>0</sub> Output*
WRITE (Write data)	1	01	A <sub>5</sub> to A <sub>0</sub>	XA <sub>6</sub> to A <sub>0</sub>	A <sub>7</sub> to A <sub>0</sub>	D <sub>15</sub> to D <sub>0</sub> Input
ERASE (Erase data)	1	11	A <sub>5</sub> to A <sub>0</sub>	XA <sub>6</sub> to A <sub>0</sub>	A <sub>7</sub> to A <sub>0</sub>	—
EWEN (Program enable)	1	00	11xxxx	11xxxxxx	11xxxxxx	—
EWDS (Program disable)	1	00	00xxxx	00xxxxxx	00xxxxxx	—

x : Doesn't matter.

\* : When 16-bit data of the specified address is output, the data of the next address is output.

■ **Absolute Maximum Ratings**

Table 3

Parameter	Symbol	Ratings	Unit
Power supply voltage	V <sub>CC</sub>	-0.3 to +7.0	V
Input voltage	V <sub>IN</sub>	-0.3 to V <sub>CC</sub> + 0.3	V
Output voltage	V <sub>OUT</sub>	-0.3 to V <sub>CC</sub>	V
Storage temperature under bias	T <sub>bias</sub>	-50 to +95	°C
Storage temperature	T <sub>stg</sub>	-65 to +150	°C

■ Recommended Operating Conditions

Table 4

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Power supply voltage	V <sub>CC</sub>	Read Operation Write Enable/Disable	1.8	—	5.5	V
		Write Operation	1.8	—	5.5	V
High level input voltage	V <sub>IH</sub>		0.8 × V <sub>CC</sub>	—	V <sub>CC</sub>	V
Low level input voltage	V <sub>IL</sub>		0.0	—	0.2 × V <sub>CC</sub>	V
Operating temperature	T <sub>opr</sub>		-40	—	+85	°C

■ Pin Capacitance

Table 5

(T<sub>a</sub> = 25°C, f = 1.0 MHz, V<sub>CC</sub> = 5 V)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Input Capacitance	C <sub>IN</sub>	V <sub>IN</sub> = 0 V	—	—	8	pF
Output Capacitance	C <sub>OUT</sub>	V <sub>OUT</sub> = 0 V	—	—	10	pF

■ Endurance

Table 6

Parameter	Symbol	Min.	Typ.	Max.	Unit
Endurance	N <sub>w</sub>	10 <sup>5</sup>	—	—	cycles/word

■ DC Electrical Characteristics

Table 7

Parameter	Smb1	Conditions	V <sub>CC</sub> = 4.5 V to 5.5 V			V <sub>CC</sub> = 2.7 V to 4.5 V			V <sub>CC</sub> = 1.8 to 2.7 V			Unit
			Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	
Current consumption (READ)	I <sub>CC1</sub>	DO unloaded	—	—	0.8	—	—	0.6	—	—	0.4	mA
Current consumption (PROGRAM)	I <sub>CC2</sub>	DO unloaded	—	—	2.0	—	—	1.5	—	—	1.0	mA

Table 8

Parameter	Smb1	Conditions	V <sub>CC</sub> = 4.5 V to 5.5 V			V <sub>CC</sub> = 2.7 to 4.5 V			V <sub>CC</sub> = 1.8 to 2.7 V			Unit
			Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	
Standby current consumption	I <sub>SB</sub>	CS = GND DO = Open Other input: Connected to V <sub>CC</sub> or GND	—	—	0.8	—	—	0.6	—	—	0.4	μA
Input leakage current	I <sub>LI</sub>	V <sub>IN</sub> = GND to V <sub>CC</sub>	—	0.1	1.0	—	0.1	1.0	—	0.1	1.0	μA
Output leakage current	I <sub>LO</sub>	V <sub>OUT</sub> = GND to V <sub>CC</sub>	—	0.1	1.0	—	0.1	1.0	—	0.1	1.0	μA
Low level output voltage	V <sub>OL</sub>	I <sub>OL</sub> = 2.1 mA	—	—	0.45							V
		I <sub>OL</sub> = 100 μA	—	—	0.1	—	—	0.1	—	—	0.1	V
High level output voltage	V <sub>OH</sub>	I <sub>OH</sub> = -400 μA	2.4	—	—							V
		I <sub>OH</sub> = -100 μA	V <sub>CC</sub> -0.7	—	—	V <sub>CC</sub> -0.7	—	—				V
		I <sub>OH</sub> = -10 μA	V <sub>CC</sub> -0.7	—	—	V <sub>CC</sub> -0.7	—	—	V <sub>CC</sub> -0.3	—	—	V
Write enable latch data hold voltage	V <sub>DH</sub>	Only when write disable mode	1.5	—	—	1.5	—	—	1.5	—	—	V
Pull-Down Current	I <sub>PD</sub>	PROTECT Terminal = V <sub>CC</sub>	15	—	80	4	—	50	1	—	15	μA

■ AC Electrical Characteristics

Table 9 Measuring conditions

Input pulse voltage	$0.1 \times V_{CC}$ to $0.9 \times V_{CC}$
Output reference voltage	$0.5 \times V_{CC}$
Output load	100pF

Table 10

Parameter	Symb	$V_{CC} = 4.5$ to $5.5V$			$V_{CC} = 2.7$ to $4.5V$			$V_{CC} = 1.8$ to $2.7V$			Unit
		Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	
CS setup time	$t_{CSS}$	0.2	—	—	0.4	—	—	1.0	—	—	$\mu s$
CS hold time	$t_{CSH}$	0.2	—	—	0.4	—	—	1.0	—	—	$\mu s$
CS deselect time	$t_{CDS}$	0.2	—	—	0.2	—	—	0.4	—	—	$\mu s$
Data setup time	$t_{DS}$	0.2	—	—	0.4	—	—	0.8	—	—	$\mu s$
Data hold time	$t_{DH}$	0.2	—	—	0.4	—	—	0.8	—	—	$\mu s$
Output delay time	$t_{PD}$	—	—	0.4	—	—	1.0	—	—	2.0	$\mu s$
Clock frequency	$f_{SK}$	0	—	2.0	0	—	0.5	—	—	0.25	MHz
Clock pulse width	$t_{SKH}$ $t_{SKL}$	0.25	—	—	1.0	—	—	2.0	—	—	$\mu s$
Output disable time	$t_{HZ1}$ $t_{HZ2}$	0	—	0.15	0	—	0.5	0	—	1.0	ns
Output enable time	$t_{SV}$	0	—	0.15	0	—	0.5	0	—	1.0	ns
Programming time	$t_{PR}$	—	4.0	10.0	—	4.0	10.0	—	4.0	10.0	ms

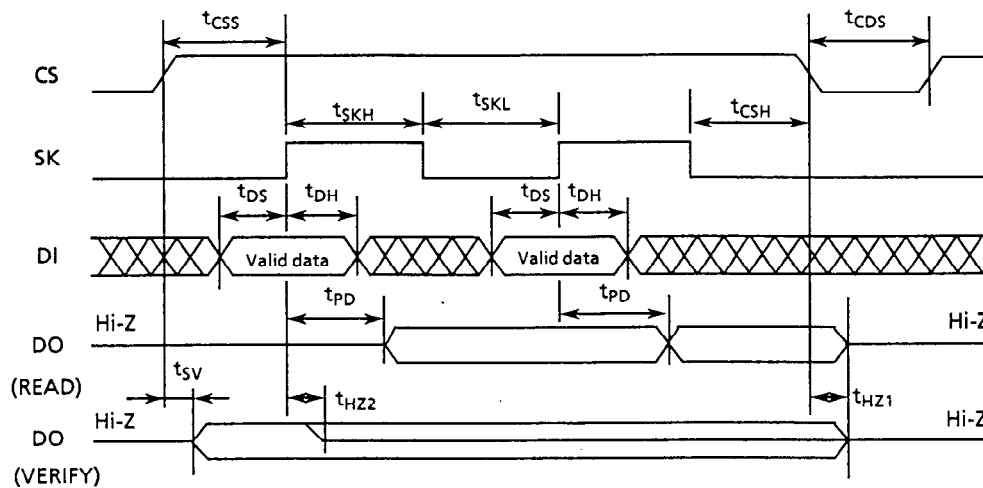


Figure 3 Timing Chart

■ Operation

Instructions (in the order of start-bit, instruction, address, and data) are latched to DI in synchronization with the rising edge of SK after CS goes high. A start-bit can only be recognized when the high of DI is latched at the rising edge of SK after changing CS to high, it is impossible for it to be recognized as long as DI is low, even if there are SK pulses after CS goes high. Any SK pulses input while DI is low before receiving a start-bit are called "dummy clocks." The number of clocks transmitted by the serial interface in a CPU and the number of clocks needed for operation of the serial memory IC can be adjusted by inserting several dummy clocks before a start-bit. Instruction finishes when CS goes low, where it must be low between commands during  $t_{CD}$ .

All input, including DI and SK signals, is ignored while CS is low, which is stand-by mode.

1. Read

The READ instruction reads data from a specified address. After A0 is latched at the rising edge of SK, DO output changes from a high-impedance state (Hi-Z) to low level output. 16-bit data is continuously output in synchronization with the rise of SK.

When all of the data (D<sub>15</sub> to D<sub>0</sub>) in the specified address has been read, the data in the next address can be read with the input of another SK clock. Thus, the data over whole area of the memory can be read by continuously inputting SK clocks as long as CS is high.

The last address (A<sub>n</sub> ... A<sub>1</sub> A<sub>0</sub> = 1 ... 11) rolls over to the top address (A<sub>n</sub> ... A<sub>0</sub> = 0 ... 00).

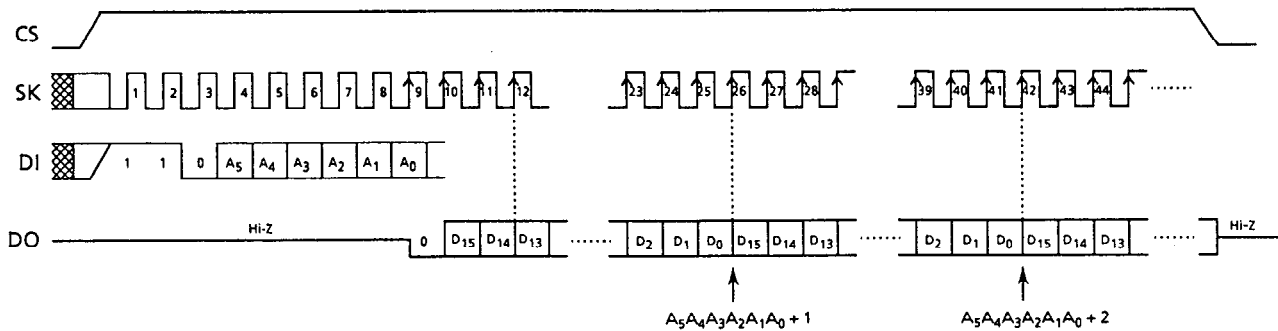


Figure 4 Read Timing (S-29L131A)

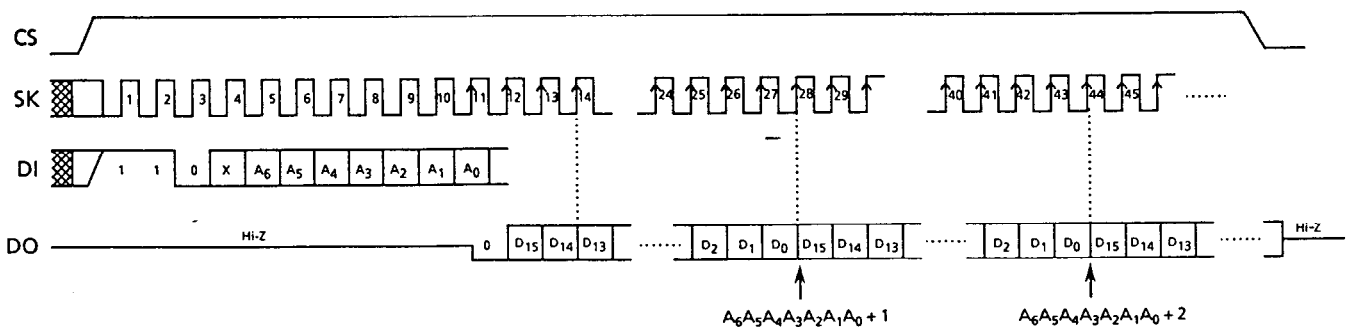


Figure 5 Read Timing (S-29L221A)

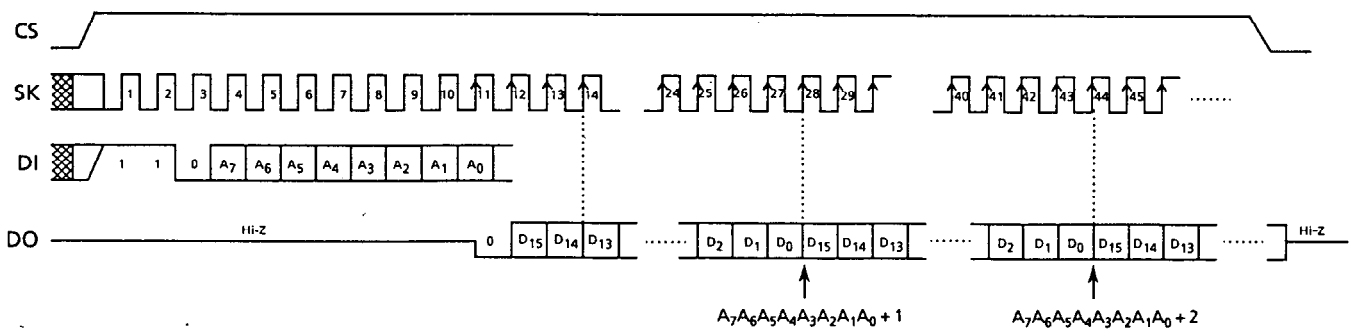


Figure 6 Read Timing (S-29L331A)

## 2. Write (WRITE, ERASE)

There are two write instructions, WRITE, ERASE. Each automatically begins writing to the non-volatile memory when CS goes low at the completion of the specified clock input.

The write operation is completed in 10 ms ( $t_{PR}$  Max.), and the typical write period is less than 5 ms. In the S-29LXX1A Series, it is easy to VERIFY the completion of the write operation in order to minimize the write cycle by setting CS to high and checking the DO pin, which is low during the write operation and high after its completion. This VERIFY procedure can be executed over and over again. There are two methods to detect a change in the DO output. One is to detect a change from low to high setting CS to high, and the other is to detect a change from low to high as a result of repetitious operations of returning the CS to low after setting CS to high and checking the DO output.

Because all SK and DI inputs are ignored during the write operation, any input of instruction will also be disregarded. When DO outputs high after completion of the write operation or if it is in the high-impedance state (Hi-Z), the input of instructions is available. Even if the DO pin remains high, it will enter the high-impedance state upon the recognition of a high of DI (start-bit) attached to the rising edge of an SK pulse.

DI input should be low during the VERIFY procedure.



2.1 WRITE

This instruction writes 16-bit data to a specified address.

After changing CS to high, input a start-bit, op-code (WRITE), address, and 16-bit data. If there is a data overflow of more than 16 bits, only the last 16-bits of the data is considered valid. Changing CS to low will start the WRITE operation. It is not necessary to make the data "1" before initiating the WRITE operation.

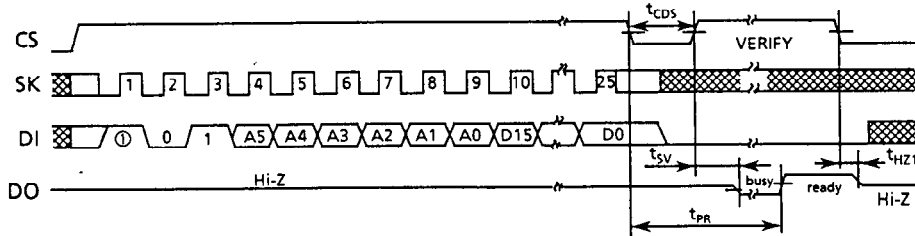


Figure 7 WRITE Timing (S-29L131A)

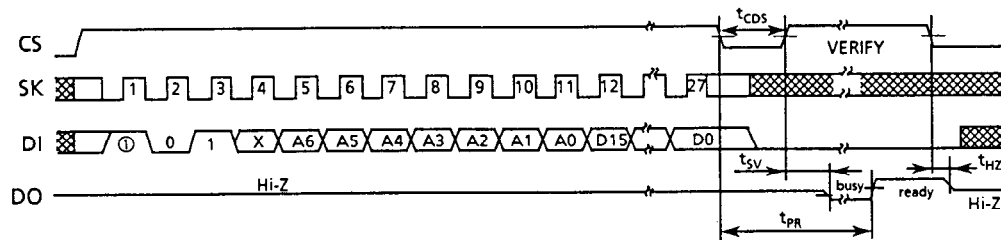


Figure 8 WRITE Timing (S-29L221A)

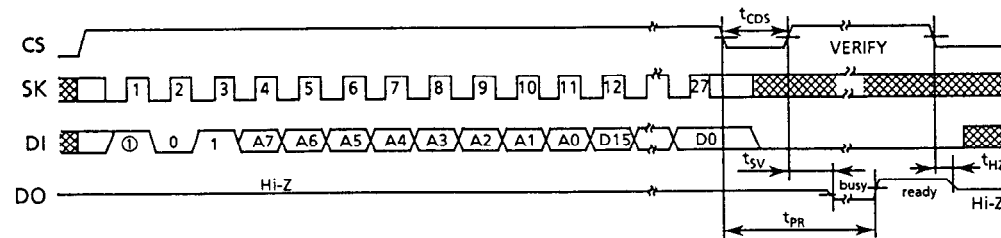


Figure 9 WRITE Timing (S-29L331A)

2.2 ERASE

This command erases 16-bit data in a specified address.

After changing CS to high, input a start-bit, op-code (ERASE), and address. It is not necessary to input data. Changing CS to low will start the ERASE operation, which changes every bit of the 16 bit data to "1."

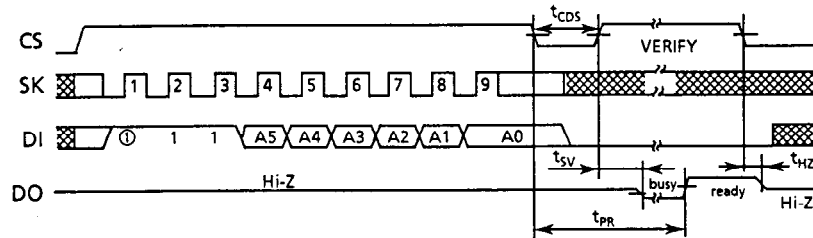


Figure 10 ERASE Timing (S-29L131A)

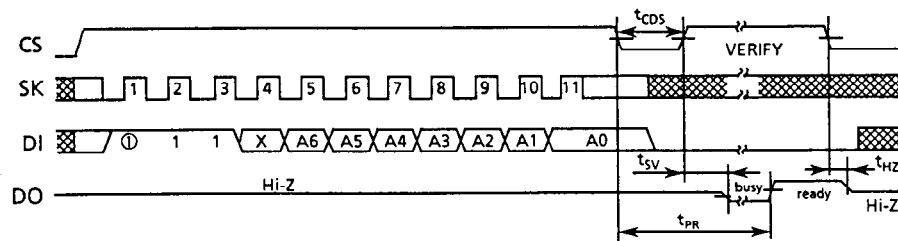


Figure 11 ERASE Timing (S-29L221A)

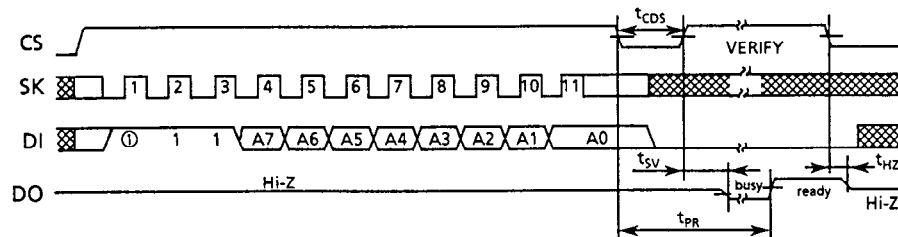


Figure 12 ERASE Timing (S-29L331A)

**CMOS SERIAL E<sup>2</sup>PROM  
S-29LXX1A Series**

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3. Write enable (EWEN) and Write disable (EWDS)

The EWEN instruction puts the S-29LXX1A Series into write enable mode, which accepts WRITE, ERASE instructions. The EWDS instruction puts the S-29LXX1A Series into write disable mode, which refuses WRITE, ERASE instructions.

The S-29LXX1A Series powers on in write disable mode, which protects data against unexpected, erroneous write operations caused by noise and/or CPU malfunctions. It should be kept in write disable mode except when performing write operations.

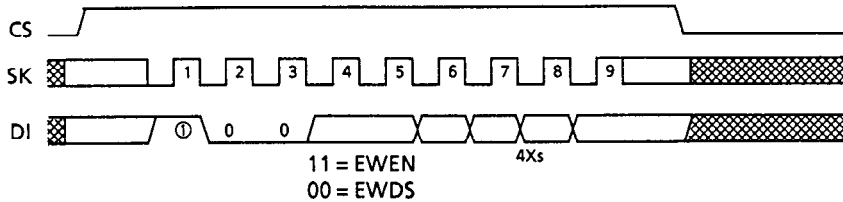


Figure 13 EWEN/EWDS Timing (S-29L131A)

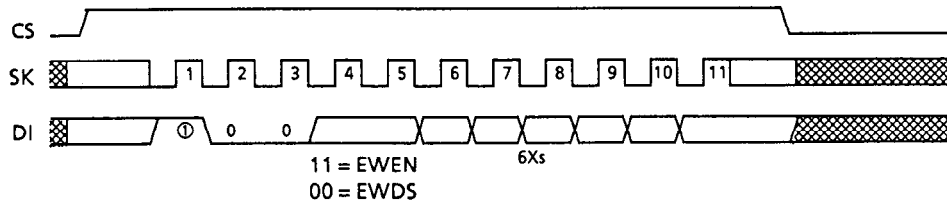


Figure 14 EWEN/EWDS Timing (S-29L221A)

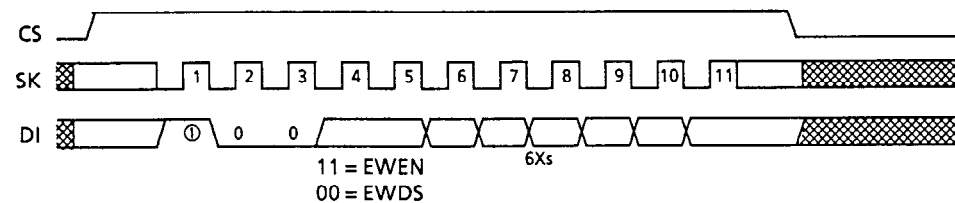


Figure 15 EWEN/EWDS Timing (S-29L331A)

### ■ Receiving a Start-Bit

A start-bit can be recognized by latching the high level of DI at the rising edge of SK after changing CS to high (Start-Bit Recognition). The write operation begins by inputting the write instruction and setting CS to low. The DO pin then outputs low during the write operation and high at its completion by setting CS to high (Verify Operation). Therefore, only after a write operation, in order to accept the next command by having CS go high, the DO pin is switched from a state of high-impedance to a state of data output; but if it recognizes a start-bit, the DO pin returns to a state of high-impedance (see Figure 3).

Make sure that data output from the CPU does not interfere with the data output from the serial memory IC when you configure a 3-wire interface by connecting DI input pin and DO output pin. Such interference may cause a start-bit fetch problem.

### ■ Three-wire Interface (DI-DO direct connection)

Although the normal configuration of a serial interface is a 4-wire interface to CS, SK, DI, and DO, a 3-wire interface is also a possibility by connecting DI and DO. However, since there is a possibility that the DO output from the serial memory IC will interfere with the data output from the CPU with a 3-wire interface, install a resistor between DI and DO in order to give preference to data output from the CPU to DI (See Figure 16).

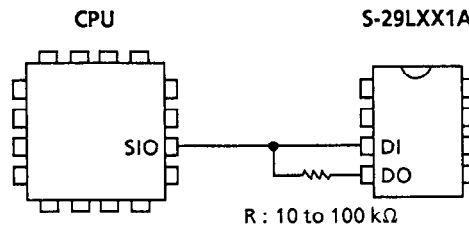


Figure 16

### ■ Memory Protection

The S-29LXX1A Series is capable of protecting the memory. So, the contents of the memory will not be miswritten due to error run or malfunction of the CPU. When the  $\overline{\text{PROTECT}}$  terminal is connected to GND or OPEN, write to Bank 1 in the memory array is prohibited (50% of the memory can be protected starting from address 00). Because the pull-down resistance is connected to the  $\overline{\text{PROTECT}}$  terminal internally, the memory can be automatically protected when the  $\overline{\text{PROTECT}}$  terminal is OPEN. When the protection is valid, the data in the memory of Bank 1 will not be rewritten. However, because the write control circuit inside the IC functions, the next instruction cannot be executed during the time period of writing ( $t_{PR}$ ). While write instruction is being input and write is being executed, always connect the  $\overline{\text{PROTECT}}$  terminal to "H," "L" or OPEN, and leave the input signal unchanged (see Figure 17).

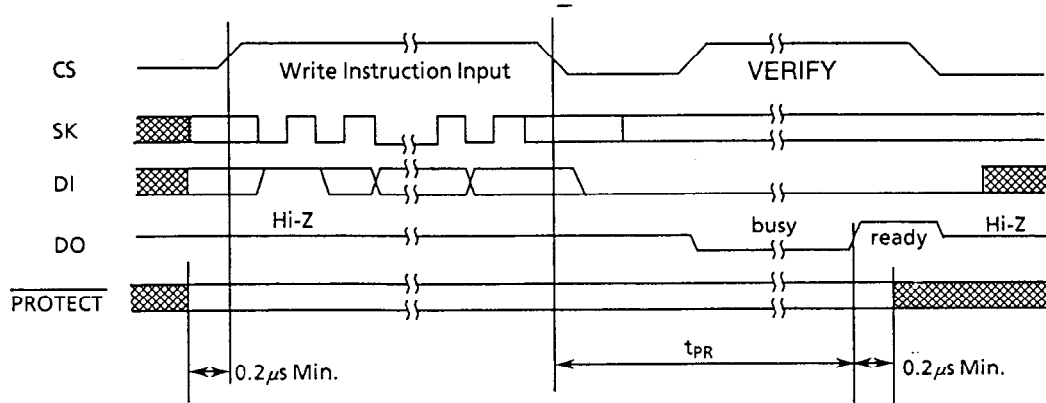


Figure 17 PROTECT Terminal Input Signal Timing

CMOS SERIAL E<sup>2</sup>PROM  
S-29LXX1A Series

■ Dimensions (Unit : mm)

1. 8-pin SOP

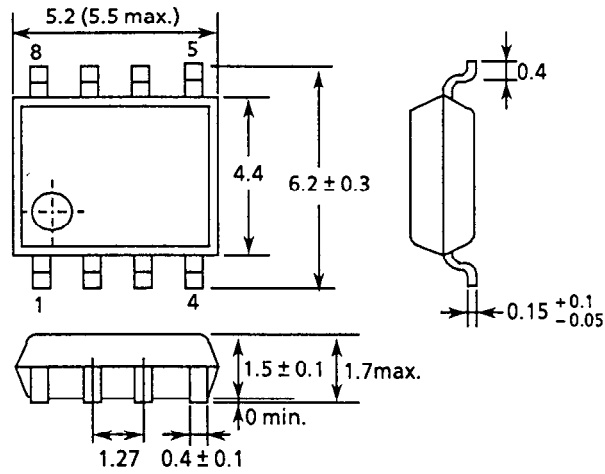


Figure 18

2. 8-pin SSOP

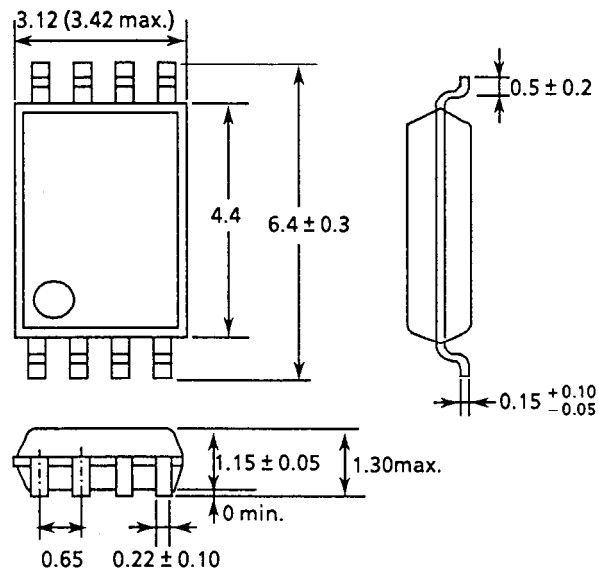


Figure 19

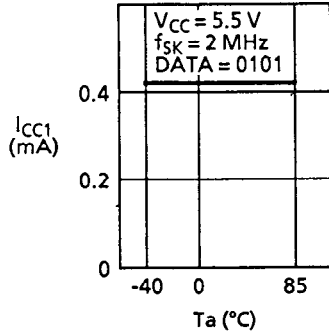
■ Ordering Information

S-29LXX1A	XXX		
		Package	DFE : SOP2 FS : SSOP
		Product name	S-29L131A : 1K-bit S-29L221A : 2K-bit S-29L331A : 4K-bit

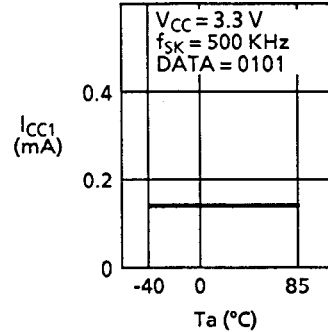
■ Characteristics

1. DC Characteristics

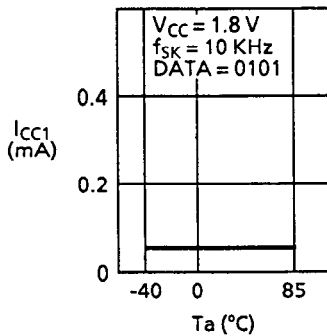
1.1 Current consumption (READ)  $I_{CC1}$  — Ambient temperature  $T_a$



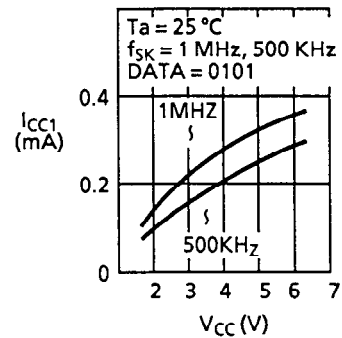
1.2 Current consumption (READ)  $I_{CC1}$  — Ambient temperature  $T_a$



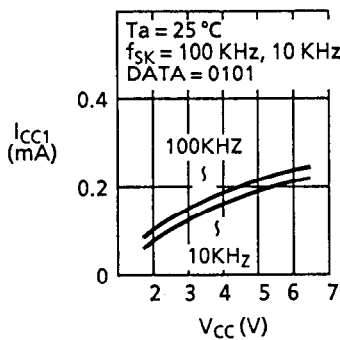
1.3 Current consumption (READ)  $I_{CC1}$  — Ambient temperature  $T_a$



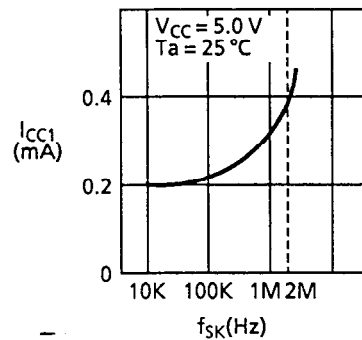
1.4 Current consumption (READ)  $I_{CC1}$  — Power supply voltage  $V_{CC}$



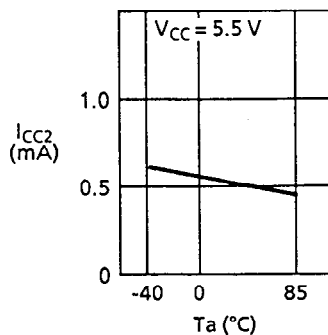
1.5 Current consumption (READ)  $I_{CC1}$  — Power supply voltage  $V_{CC}$



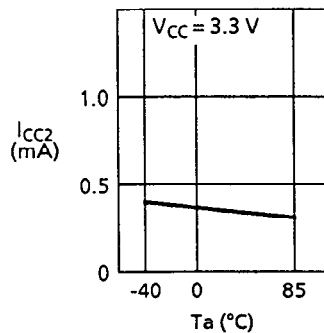
1.6 Current consumption (READ)  $I_{CC1}$  — Clock frequency  $f_{sk}$



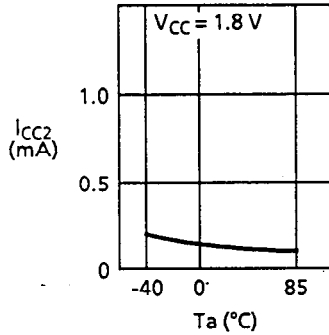
1.7 Current consumption (PROGRAM)  $I_{CC2}$  — Ambient temperature  $T_a$



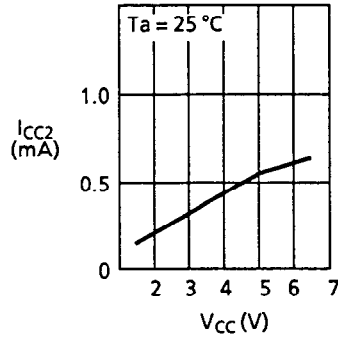
1.8 Current consumption (PROGRAM)  $I_{CC2}$  — Ambient temperature  $T_a$



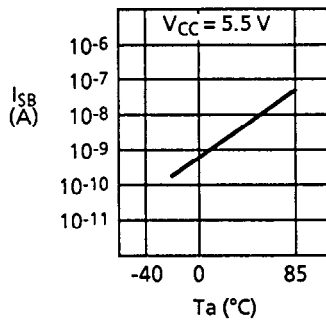
1.9 Current consumption (PROGRAM)  $I_{CC2}$  — Ambient temperature  $T_a$



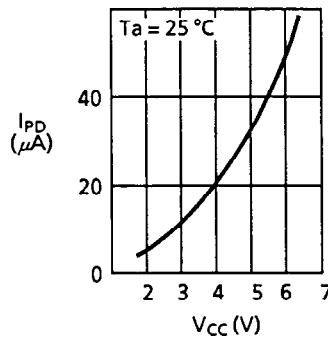
1.10 Current consumption (PROGRAM)  $I_{CC2}$  — Power supply voltage  $V_{CC}$



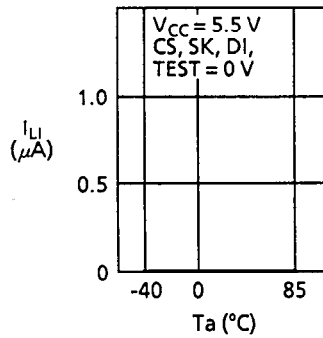
1.11 Standby current consumption  $I_{SB}$  — Ambient temperature  $T_a$



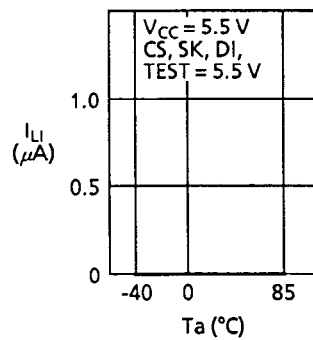
1.12 Pull-Down current  $I_{PD}$  — Power supply voltage  $V_{CC}$



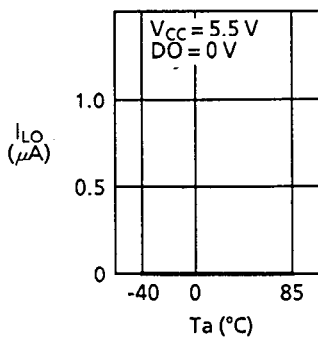
1.13 Input leakage current  $I_{LI}$  — Ambient temperature  $T_a$



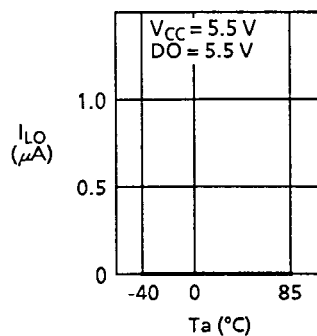
1.14 Input leakage current  $I_{LI}$  — Ambient temperature  $T_a$



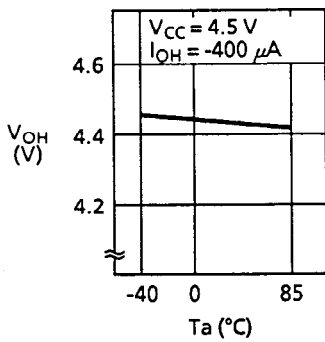
1.15 Output leakage current  $I_{LO}$  — Ambient temperature  $T_a$



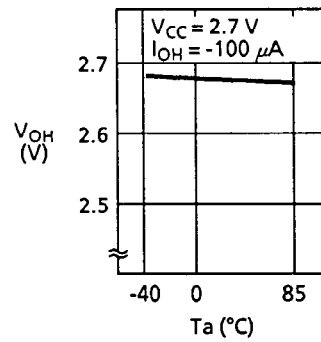
1.16 Output leakage current  $I_{LO}$  — Ambient temperature  $T_a$



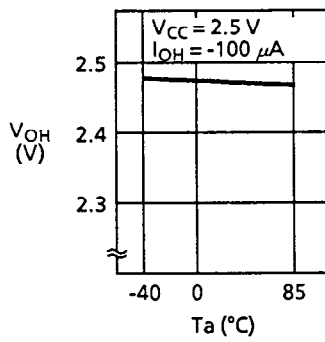
1.17 High level output voltage  $V_{OH}$  - Ambient temperature  $T_a$



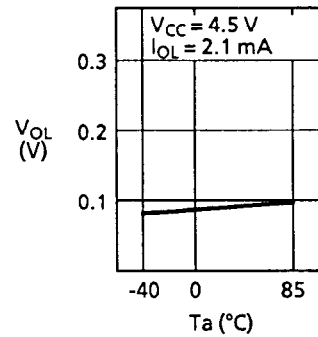
1.18 High level output voltage  $V_{OH}$  - Ambient temperature  $T_a$



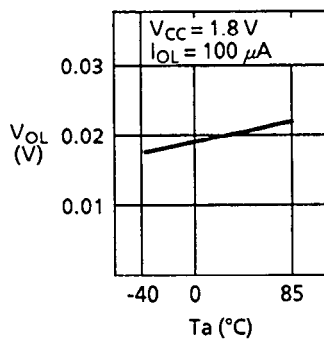
1.19 High level output voltage  $V_{OH}$  - Ambient temperature  $T_a$



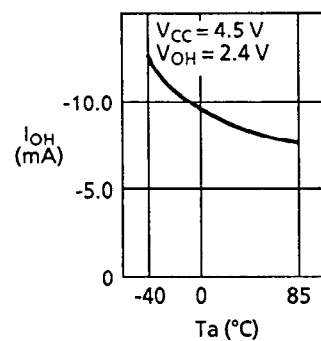
1.20 Low level output voltage  $V_{OL}$  - Ambient temperature  $T_a$



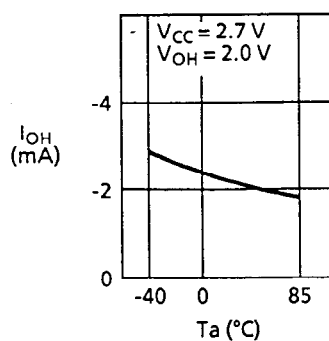
1.21 Low level output voltage  $V_{OL}$  - Ambient temperature  $T_a$



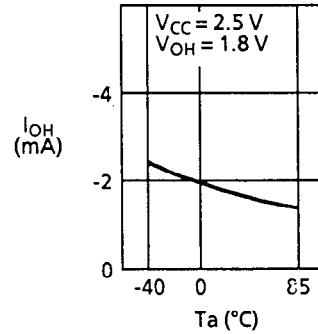
1.22 High level output current  $I_{OH}$  - Ambient temperature  $T_a$



1.23 High level output current  $I_{OH}$  - Ambient temperature  $T_a$

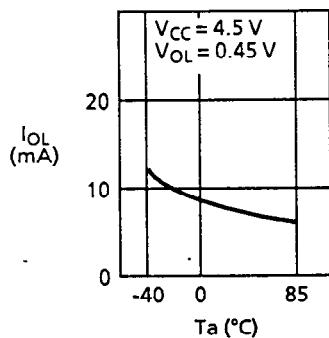


1.24 High level output current  $I_{OH}$  - Ambient temperature  $T_a$

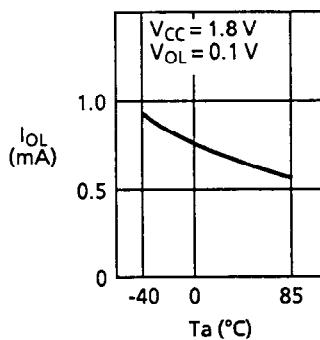




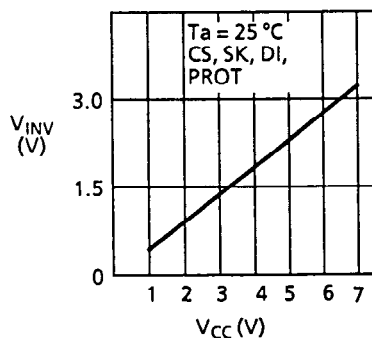
1.25 Low level output current  $I_{OL}$  - Ambient temperature  $T_a$



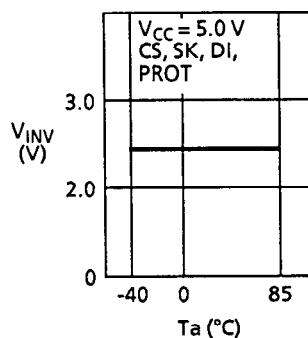
1.26 Low level output current  $I_{OL}$  - Ambient temperature  $T_a$



1.27 Input inversion voltage  $V_{INV}$  - Power supply voltage  $V_{CC}$

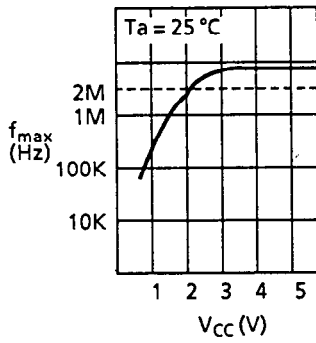


1.28 Input inversion voltage  $V_{INV}$  - Ambient temperature  $T_a$

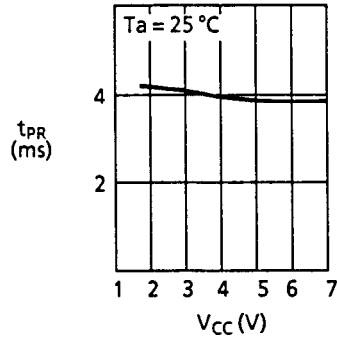


2. AC Characteristics

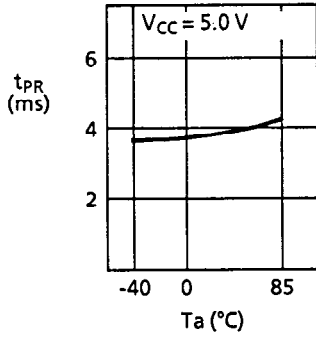
2.1 Maximum operating frequency  $f_{max}$  - Power supply voltage  $V_{CC}$



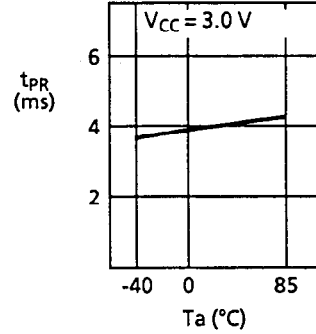
2.2 Program time  $t_{PR}$  - Power supply voltage  $V_{CC}$



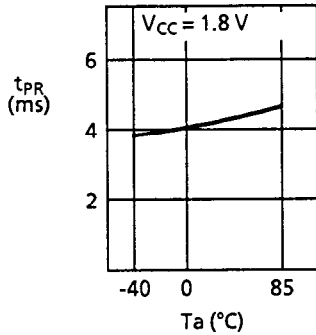
2.3 Program time  $t_{PR}$  - Ambient temperature  $T_a$



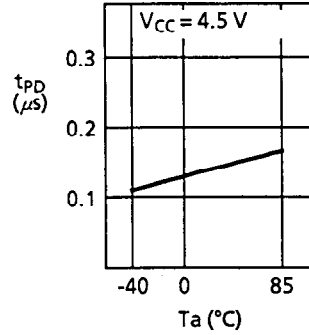
2.4 Program time  $t_{PR}$  - Ambient temperature  $T_a$



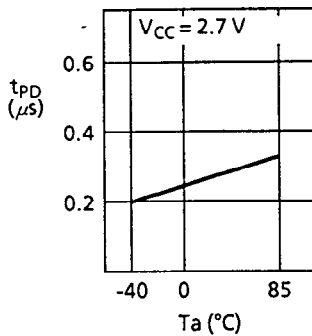
2.5 Program time  $t_{PR}$  - Ambient temperature  $T_a$



2.6 Data output delay time  $t_{PD}$  - Ambient temperature  $T_a$



2.7 Data output delay time  $t_{PD}$  - Ambient temperature  $T_a$



2.7 Data output delay time  $t_{PD}$  - Ambient temperature  $T_a$

